SN54ABT834 ... JT PACKAGE

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- State-of-the-Art EPIC-IIB ™ BiCMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per **JEDEC Standard JESD-17**
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 1 V at  $V_{CC}$  = 5 V,  $T_A$  = 25°C
- High-Drive Outputs (–32-mA I<sub>OH</sub>, 64-mA I<sub>OI</sub>)
- Parity Error Flag With Parity Generator/Checker
- Register for Storage of the Parity Error Flag
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

#### description

The 'ABT834 8-bit to 9-bit parity transceiver is designed for communication between data buses. When data is transmitted from the A bus to the B bus, a parity bit is generated. When data is transmitted from the B bus to the A bus with its corresponding parity bit, the open-collector parity-error (ERR) output indicates whether or not an error in the B data has occurred. The output-enable (OEA and OEB) inputs can be used to disable the device so that the buses are effectively isolated. The 'ABT834 provides inverted data at its outputs.

A 9-bit parity generator/checker generates a parity-odd (PARITY) output and monitors the parity of the I/O ports with the ERR flag. The parity-error output is clocked into the register on the rising edge of the clock (CLK) input. The error flag register is cleared with a low pulse on the clear  $(\overline{\text{CLR}})$  input. When both  $\overline{\text{OEA}}$  and  $\overline{\text{OEB}}$  are low, data is transferred from the A bus to the B bus and inverted parity is generated. Inverted parity is a forced error condition that gives the designer more system diagnostic capability.

| SN74ABT834 DW OR NT PACKAGE<br>(TOP VIEW) |     |    |                 |  |  |  |  |  |  |
|---|-----|----|-----------------|--|--|--|--|--|--|
| OEA [                                     | 1 U | 24 | V <sub>CC</sub> |  |  |  |  |  |  |
| A1 [                                      | 2   | 23 | B1              |  |  |  |  |  |  |
| A2 [                                      | 3   | 22 | B2              |  |  |  |  |  |  |
| A3 [                                      | 4   | 21 | B3              |  |  |  |  |  |  |
| A4 [                                      | 5   | 20 | B4              |  |  |  |  |  |  |
| A5 [                                      | 6   | 19 | B5              |  |  |  |  |  |  |
| A6 [                                      | 7   | 18 | B6              |  |  |  |  |  |  |
| A7 [                                      | 8   | 17 | B7              |  |  |  |  |  |  |
| A8 [                                      | 9   | 16 | B8              |  |  |  |  |  |  |
| ERR [                                     | 10  | 15 | PARITY          |  |  |  |  |  |  |
| CLR [                                     | 11  | 14 | OEB             |  |  |  |  |  |  |
| GND [                                     | 12  | 13 | CLK             |  |  |  |  |  |  |

#### SN54ABT834 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT834 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ABT834 is characterized for operation from -40°C to 85°C.

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|        | FUNCTION TABLE |                  |                      |                     |      |               |     |    |        |                   |  |  |
|--------|----------------|------------------|----------------------|---------------------|------|---------------|-----|----|--------|-------------------|--|--|
| INPUTS |                |                  |                      |                     | OUTP | UT AND I/O    |     |    |        |                   |  |  |
| OEB    | OEA            | CLR              | CLK                  | Ai<br>Σ OF H's      |      | Bi†<br>)F L's | A B |    | PARITY | ERR‡              | FUNCTION                                     |  |
| L      | Н              | Х                | Х                    | Odd<br>Even         |      | NA            | NA  | Ā  | H<br>L | NA                | A data to B bus and generate parity          |  |
| Н      | L              | Н                | Ť                    | NA                  |      | Ddd<br>Iven   | B   | NA | NA     | H<br>L            | B data to A bus and check parity             |  |
| Х      | Х              | L                | Х                    | Х                   |      | Х             | Х   | NA | NA     | Н                 | Check error flag register                    |  |
| н      | н              | H<br>L<br>H<br>H | No↑<br>No↑<br>↑<br>↑ | X<br>X<br>O<br>Even | d    | X<br>d        | Z   | Z  | Z      | NC<br>H<br>L<br>H | IsolationS                                   |  |
| L      | L              | х                | Х                    | Odd<br>Even         |      | NA            | NA  | Ā  | L<br>H | NA                | A data to B bus and generate inverted parity |  |

NA = not applicable, NC = no change, X = don't care

<sup>†</sup> Summation of high-level inputs includes PARITY along with Bi inputs.

<sup>‡</sup> Output states shown assume the ERR output was previously high.

 $\$  In this mode, the  $\overline{\text{ERR}}$  output (when clocked) shows inverted parity of the A bus.

### logic symbol¶



 $\P$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for DW, JT, and NT packages.



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#### ERROR FLAG FUNCTION TABLE

| INP | UTS        | INTERNAL OUTPUT<br>TO DEVICE PRE-STATE |                                  |   | FUNCTION |
|-----|------------|--|----------------------------------|---|----------|
| CLR | CLK        | POINT "P"                              | INT "P" ERR <sub>n-1</sub> † ERR |   |          |
| Н   | ↑          | Н                                      | Н                                | Н |          |
| н   | $\uparrow$ | Х                                      | L                                | L | Sample   |
| н   | $\uparrow$ | L                                      | Х                                | L |          |
| L   | Х          | Х                                      | Х                                | Н | Clear    |

<sup>†</sup> The state of the ERR output before any changes at CLR, CLK, or point "P".



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#### error-flag waveforms



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

| Supply voltage range, V <sub>CC</sub>                     |                              | –0.5 V to 7 V   |
|---|------------------------------|-----------------|
| Input voltage range, VI (except I/O ports) (see N         | ote 1)                       | –0.5 V to 7 V   |
| Voltage range applied to any output in the high s         | state or power-off state, VO | –0.5 V to 5.5 V |
| Current into any output in the low state, IO: SN          | 54ABT834                     |                 |
| SN  | 74ABT834                     | 128 mA          |
| Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0) |                              | –18 mA          |
| Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0)       |                              | –50 mA          |
| Maximum power dissipation at $T_A = 55^{\circ}C$ (in stil | l air): DW package           |                 |
|   | ,                            | 1.3 W           |
| Storage temperature range                                 |                              |                 |
|   |                              |                 |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



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#### recommended operating conditions (see Note 2)

|                       |                                    |                 | SN54A | BT834 | SN74A |     |      |
|-----------------------|------------------------------------|-----------------|-------|-------|-------|-----|------|
|                       |                                    |                 | MIN   | MAX   | MIN   | MAX | UNIT |
| Vcc                   | Supply voltage                     |                 | 4.5   | 5.5   | 4.5   | 5.5 | V    |
| VIH                   | High-level input voltage           |                 | 2     |       | 2     |     | V    |
| VIL                   | Low-level input voltage            |                 | 0.8   |       | 0.8   | V   |      |
| VI                    | Input voltage                      |                 | 0     | VCC   | 0     | VCC | V    |
| VOH                   | High-level output voltage          | ERR             |       | 5.5   |       | 5.5 | V    |
| ЮН                    | High-level output current          |                 |       | -24   |       | -32 | mA   |
| IOL                   | Low-level output current           | Except ERR      |       | 48    |       | 64  | mA   |
| $\Delta t / \Delta v$ | Input transition rise or fall rate | Outputs enabled |       | 5     |       | 5   | ns/V |
| TA                    | Operating free-air temperature     |                 | -55   | 125   | -40   | 85  | °C   |

NOTE 2: Unused or floating pins (input or I/O) must be held high or low.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER          | TEST CONDITIONS                              |                              |                  | Т   | A = 25°0 |       | SN54AE | 3T834 | SN74ABT834 |      |       |  |  |  |
|--------------------|--|------------------------------|------------------|-----|----------|-------|--------|-------|------------|------|-------|--|--|--|
| PARAMETER          |  |                              |                  | MIN | TYP†     | MAX   | MIN    | MAX   | MIN        | MAX  |       |  |  |  |
| VIK                | V <sub>CC</sub> = 4.5 V,                     | l <sub>l</sub> = –18 mA      |                  |     |          | -1.2  |        | -1.2  |            | -1.2 | V     |  |  |  |
|                    | V <sub>CC</sub> = 4.5 V,                     | $I_{OH} = -3 \text{ mA}$     |                  | 2.5 |          |       | 2.5    |       | 2.5        |      |       |  |  |  |
| X                  | V <sub>CC</sub> = 5 V,                       | $I_{OH} = -3 \text{ mA}$     | All outputs      | 3   |          |       | 3      |       | 3          |      |       |  |  |  |
| VOH                | V <sub>CC</sub> = 4.5 V,                     | $I_{OH} = -24 \text{ mA}$    | except ERR       | 2   |          |       | 2      |       |            |      | V     |  |  |  |
|                    | V <sub>CC</sub> = 4.5 V,                     | $I_{OH} = -32 \text{ mA}$    |                  | 2‡  |          |       |        |       | 2          |      |       |  |  |  |
|                    | V <sub>CC</sub> = 4.5 V,                     | I <sub>OL</sub> = 24 mA      |                  |     |          | 0.55  |        | 0.55  |            |      | v     |  |  |  |
| VOL                | V <sub>CC</sub> = 4.5 V,                     | I <sub>OL</sub> = 64 mA      |                  |     |          | 0.55‡ |        |       |            | 0.55 | 5 V   |  |  |  |
| ЮН                 | V <sub>CC</sub> = 4.5 V,                     | V <sub>OH</sub> = 4.5 V      | ERR              |     |          |       |        |       |            |      | μΑ    |  |  |  |
| L.                 | V <sub>CC</sub> = 5.5 V,                     |                              | Control inputs   |     |          | ±1    |        | ±1    |            | ±1   |       |  |  |  |
| ł                  | $V_I = V_{CC} \text{ or } GND$               |                              | A or B ports     |     |          | ±100  |        | ±100  |            | ±100 | 00 μA |  |  |  |
| ۱ <sub>IL</sub>    | $V_{CC} = 0 V,$                              | V <sub>I</sub> = GND         | A or B ports     |     |          | -50   |        | -50   |            | -50  | μΑ    |  |  |  |
| Iozh <sup>§</sup>  | V <sub>CC</sub> = 5.5 V,                     | V <sub>O</sub> = 2.7 V       |                  |     |          | 50    |        | 50    |            | 50   | μΑ    |  |  |  |
| I <sub>OZL</sub> § | V <sub>CC</sub> = 5.5 V,                     | $V_{O} = 0.5 V$              |                  |     |          | -50   |        | -50   |            | -50  | μA    |  |  |  |
| IOFF               | $V_{CC} = 0 V,$                              | VI or VO $\leq$ 5.5 \        | /                |     |          | ±100  |        |       |            | ±100 | μΑ    |  |  |  |
| ICEX               | V <sub>CC</sub> = 5.5 V,                     | V <sub>O</sub> = 5.5 V       | Outputs high     |     |          | 50    |        | 50    |            | 50   | μΑ    |  |  |  |
| IO                 | V <sub>CC</sub> = 5.5 V,                     | V <sub>O</sub> = 2.5 V       |                  | -50 | -100     | -180  | -50    | -180  | -50        | -180 | mA    |  |  |  |
|                    | V <sub>CC</sub> = 5.5 V,                     |                              | Outputs high     |     | 1        | 250   |        | 250   |            | 250  | μΑ    |  |  |  |
| ICC                | I <sub>O</sub> = 0,                          | A or B ports                 | Outputs low      |     | 24       | 30    |        | 30    |            | 30   | mA    |  |  |  |
|                    | $V_I = V_{CC} \text{ or } GND$               |                              | Outputs disabled |     | 0.5      | 250   |        | 250   |            | 250  | μΑ    |  |  |  |
| ∆ICC <sup>#</sup>  | $V_{CC} = 5.5 V,$<br>Other inputs at $V_{C}$ | One input at 3.4<br>C or GND | · V,             |     |          | 50    |        | 50    |            | 50   | μA    |  |  |  |
| Ci                 | V <sub>I</sub> = 2.5 V or 0.5 V              |                              | Control inputs   |     |          |       |        |       |            |      | pF    |  |  |  |
| Cio                | $V_{O} = 2.5 \text{ V or } 0.5 \text{ V}$    | V                            | A or B ports     |     |          |       |        |       |            |      | pF    |  |  |  |

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V.

<sup>‡</sup>On products compliant to MIL-STD-883, Class B, this parameter does not apply.

 $\$  The parameters I<sub>OZH</sub> and I<sub>OZL</sub> include the input leakage current.

¶ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>#</sup>This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.



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# timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

|                 |                                    |          | V <sub>CC</sub> = 5 V,<br>T <sub>A</sub> = 25°C<br>MIN MAX |  | = 5 V,<br>: 25°C SN54ABT834 |     |     | SN74ABT834 |    |  |
|-----------------|------------------------------------|----------|--|--|-----------------------------|-----|-----|------------|----|--|
|                 |                                    |          |  |  | MIN                         | MAX | MIN | MAX        |    |  |
|                 |                                    | CLK high |  |  |                             |     |     |            |    |  |
| tw              | Pulse duration                     | CLK low  |  |  |                             |     |     |            | ns |  |
|                 |                                    | CLR low  |  |  |                             |     |     |            |    |  |
|                 |                                    | A port   |  |  |                             |     |     |            |    |  |
| t <sub>su</sub> | Setup time before CLK <sup>↑</sup> | CLR      |  |  |                             |     |     |            | ns |  |
| t <sub>h</sub>  | Hold time after $CLK^\uparrow$     | A port   |  |  |                             |     |     |            | ns |  |

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

| PARAMETER        | FROM<br>(INPUT) | TO<br>(OUTPUT) | V <sub>CC</sub> = 5 V,<br>T <sub>A</sub> = 25 °C |     |        | SN54AE | 3T834 | SN74AE | UNIT |     |  |  |    |
|------------------|-----------------|----------------|--|-----|--------|--------|-------|--------|------|-----|--|--|----|
|                  |                 | (001101)       | MIN  | TYP | MAX    | MIN    | MAX   | MIN    | MAX  |     |  |  |    |
| <sup>t</sup> PLH | A or B          | B or A         |  |     |        |        |       |        |      |     |  |  |    |
| <sup>t</sup> PHL | AULP            | BUIA           |  |     |        |        |       |        |      | ns  |  |  |    |
| <sup>t</sup> PZH | OE              | 05             | OF   | OF  | A or B |        |       |        |      |     |  |  | ns |
| <sup>t</sup> PZL |                 | AUB            |  |     |        |        |       |        |      | 115 |  |  |    |
| <sup>t</sup> PHZ | OE              | A or B         |  |     |        |        |       |        |      | ns  |  |  |    |
| <sup>t</sup> PLZ | OL              |                |  |     |        |        |       |        |      | 115 |  |  |    |
| <sup>t</sup> PLH | A or OE         | PARITY         |  |     |        |        |       |        |      | ns  |  |  |    |
| <sup>t</sup> PHL | AUIOE           | PARITY         |  |     |        |        |       |        |      | 115 |  |  |    |
| <sup>t</sup> PLH | CLR             | ERR            |  |     |        |        |       |        |      | ns  |  |  |    |
| <sup>t</sup> PHL | CLK             |                |  |     |        |        |       |        |      | 113 |  |  |    |



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### PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns. C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
- Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. D. The outputs are measured one at a time with one transition per measurement.
- E. t<sub>PHL</sub> is measured at 1.5 V.
- F. t<sub>PLH</sub> is measured at  $V_{OL}$  + 0.3 V.

#### Figure 1. Load Circuit and Voltage Waveforms



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